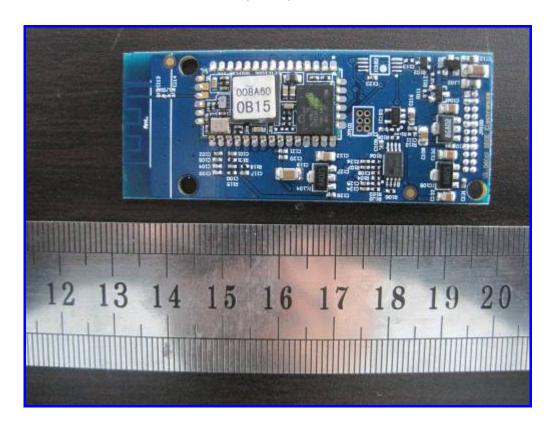
Dice Electronics. LLC

BT1DB

Model: BT1DB

8 November 2010 Report No.: 1002743-FCC-IC (This report supersedes NONE)



Modifications made to the product: None

This Test Report is Issued Under the Authority of:

Will yang

Peter Cai

Will yang

Test Engineer

Technical Manager

This test report may be reproduced in full only.

Test result presented in this test report is applicable to the representative sample only.

RF Lest Report TO: FCC Part 15,247; 2010, RSS-210 Issue 7; 2007





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Laboratory Introduction

SIEMIC, headquartered in the heart of Silicon Valley, with superior facilities in US and Asia, is one of the leading independent testing and certification facilities providing customers with one-stop shop services for Compliance Testing and Global Certifications.



In addition to <u>testing</u> and <u>certification</u>, SIEMIC provides initial design reviews and <u>compliance</u> <u>management</u> through out a project. Our extensive experience with <u>China</u>, <u>Asia Pacific</u>, <u>North America</u>, <u>European</u>, <u>and international</u> compliance requirements, assures the fastest, most cost effective way to attain regulatory compliance for the <u>global markets</u>.

Accreditations for Conformity Assessment

Country/Region	Accreditation Body	Scope
USA	FCC, A2LA	EMC, RF/Wireless, Telecom
Canada	IC, A2LA, NIST	EMC, RF/Wireless, Telecom
Taiwan	BSMI, NCC, NIST	EMC, RF, Telecom , Safety
Hong Kong	OFTA , NIST	RF/Wireless ,Telecom
Australia	NATA, NIST	EMC, RF, Telecom , Safety
Korea	KCC/RRA, NIST	EMI, EMS, RF , Telecom, Safety
Japan	VCCI, JATE, TELEC, RFT	EMI, RF/Wireless, Telecom
Mexico	NOM, COFETEL, Caniety	Safety, EMC, RF/Wireless, Telecom
Europe	A2LA, NIST	EMC, RF, Telecom , Safety

Accreditations for Product Certifications

Country	Accreditation Body	Scope
USA	FCC TCB, NIST	EMC, RF, Telecom
Canada	IC FCB , NIST	EMC, RF, Telecom
Singapore	iDA, NIST	EMC, RF, Telecom



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1 Executive Summary & EUT information

The purpose of this test programme was to demonstrate compliance of the Dice Electronics. LLC, BT1DB, and model: BT1DB against the current Stipulated Standards. The BT1DB has demonstrated compliance with the FCC 15.247:2010, RSS-210 Issue 7:2007.

EUT Information

EUT : BT1DB

Description

Model No : BT1DB Serial No : N/A

Input Power : 11.6V-13.8V dc

Classification

Per Stipulated : Spread Spectrum System/Device

Test Standard



IC ID:

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7692A-BT1DB

TECHNICAL DETAILS Purpose Compliance testing of BT1DB with stipulated standard Dice Electronics. LLC Applicant / Client 2650 Gundy Ave Signal Hill California 90755 United States Dice Electronics. LLC Manufacturer 2650 Gundy Ave Signal Hill California 90755 United States SIEMIC Nanjing (China) Laboratories NO.2-1, Longcang Dadao, Yuhua Economic Development Zone, Laboratory performing the Nanjing, China Tel:+86(25)86730128/86730129 tests Fax:+86(25)86730127 Email:info@siemic.com Test report reference 1002743-FCC-IC number Date EUT received 25 October 2010 Standard applied FCC 15.247:2010, RSS-210 Issue 7:2007 Dates of test (from - to) 28 October to 5 November 2010 No of Units: #1 Spread Spectrum System/Device **Equipment Category:** Trade Name: **Dice Electronics** Model: BT1DB **RF Operating Frequency** 2402 - 2480MHz Number of Channels: 79 Modulation: GFSK; PI/4-DQPSK; 8DPSK FCC ID: V9UBT1DB



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3 MODIFICATION

NONE

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TEST SUMMARY

The product was tested in accordance with the following specifications. All testing has been performed according to below product classification:

Spread Spectrum System/Device

Test Results Summary

Test Standard				
47 CFR Part 15.247:2010	RSS210 Issue 7: 2007	Description	Pass / Fail	
15.203		Antenna Requirement	Pass	
15.205	RSS210(A8.5)	Restricted Band of Operation	Pass	
15.207(a)	RSSGen(7.2.2)	Conducted Emissions Voltage	N/A	
15.247(a)(1)	RSS210(A8.1)	Channel Separation	Pass	
15.247(a)(1)	RSS210(A8.1)	Occupied Bandwidth	Pass	
15.247(a)(2)	RSS210(A8.2)	Bandwidth	Pass	
15.247(a)(1)(i)	RSS210(A8.1)	Number of Hopping Channels	Pass	
15.247(a)(1)(i)	RSS210(A8.1)	Time of Occupancy	Pass	
15.247(b)(2)	RSS210(A8.4)	Output Power	Pass	
15.247(c)	RSS210(A8.4)	Antenna Gain > 6 dBi	Pass	
15.247(d)	RSS210(A8.5)	Conducted Spurious Emissions	Pass	
15.209;15.247(d)	RSS210(A8.3)	Radiated Spurious Emissions	Pass	
15.247(e)	RSS210(A8.3)	Power Spectral Density	N/A	
15.247(f)	RSS210(A8.3)	Hybrid System Requirement	N/A	
15.247(g)	RSS210(A8.1)	Hopping Capability	Pass	
15.247(h)	RSS210(A8.1)	Hopping Coordination Requirement	Pass	
15.247(i)	RSSGen(5.5)	RF Exposure requirement	Pass	
15.247(d)	RSS210(A8.5)	100KHz Bandwidth of Frequency Band Edge	Pass	
	RSSGen(4.10)	Receiver Spurious Emissions	Pass	
	l	1	1	

ANSI C63.4: 2009/ RSS-Gen Issue 2: 2007

PS: All measurement uncertainties are not taken into consideration for all presented test result.

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5 MEASUREMENTS, EXAMINATION AND DERIVED RESULTS

5.1 Antenna Requirement

Requirement(s): 47 CFR §15.203

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Antenna requirement must meet at least one of the following:

- a) Antenna must be permanently attached to the device.
- b) Antenna must use a unique type of connector to attach to the device.
- c) Device must be professionally installed. Installer shall be responsible for ensuring that the correct antenna is employed with the device.

The antenna is integral antenna. The antenna gain is 0.54dBi.

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5.2 Conducted Emissions Voltage

Requirement:

	Conducted lin	Conducted limit (dBµV)		
Frequency of emission (MHz)	Quasi-peak	Average		
0.15–0.5	66 to 56*	56 to 46*		
0.5–5	56	46		
5–30	60	50		

^{*}Decreases with the logarithm of the frequency.

Procedures:

- All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR and Average detectors, are reported. All other emissions were relatively insignificant.
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
- 3. Conducted Emissions Measurement Uncertainty
 All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 9kHz 30MHz (Average & Quasi-peak) is ±3.5dB.

4. Environmental Conditions Temperature 25°C Relative Humidity 50%

Atmospheric Pressure 1019mbar

5. Test date: 28 October to 5 November 2010

Tested By: Peter Cai

N/A, this Bluetooth module is powered by battery (12V dc).

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5.3 Channel Separation

1. <u>Conducted Measurement</u>

EUT was set for low, mid, high channel with modulated mode and highest RF output power.

The spectrum analyzer was connected to the antenna terminal.

2. Environmental Conditions Temperature 25°C

Relative Humidity 50% Atmospheric Pressure 1019mbar

3. Conducted Emissions Measurement Uncertainty

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz - 40GHz is $\pm 1.5dB$.

4. Test date: 28 October to 5 November 2010

Tested By: Peter Cai

Requirement(s): Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125mW.

Procedures: The Channel Separation was measured conducted using a spectrum analyzer at low, mid, and hi channels.

Configuration: Bluetooth Mode, Basic Rate

Channel	Channel Frequency (MHz)	Channel Separation (MHz)
Low	2402	1.010
Mid	2441	1.025
High	2480	1.015

Configuration: Bluetooth Mode, EDR

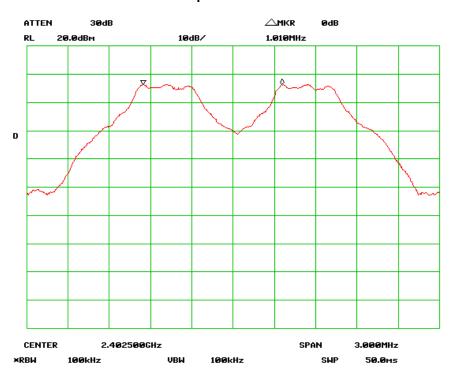
Channel	Channel Frequency (MHz)	Channel Separation (MHz)
Low	2402	1.020
Mid	2441	1.010
High	2480	1.020

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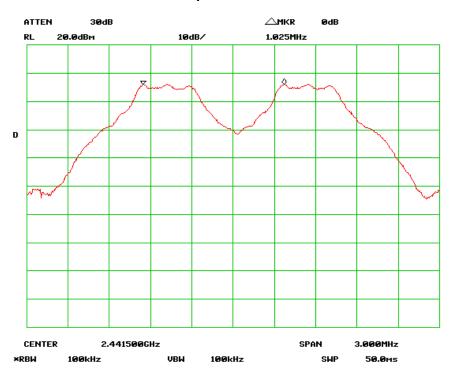
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Bluetooth Mode, Basic Rate

Channel Separation - Low Channel

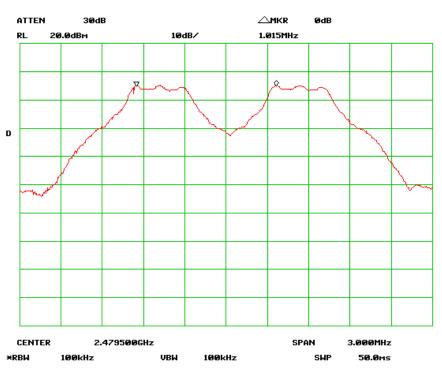


Channel Separation – Mid Channel



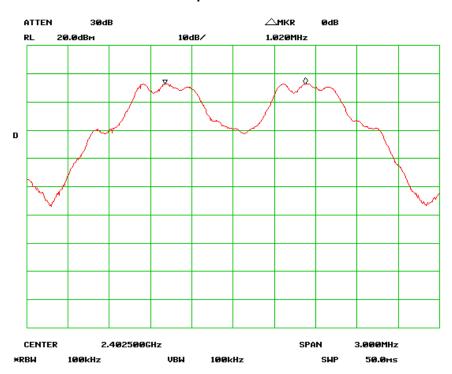
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Channel Separation – High Channel



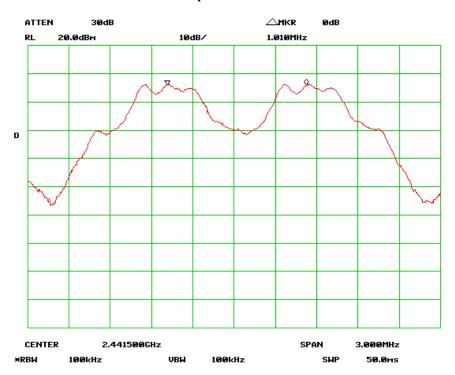
Bluetooth Mode, EDR

Channel Separation - Low Channel

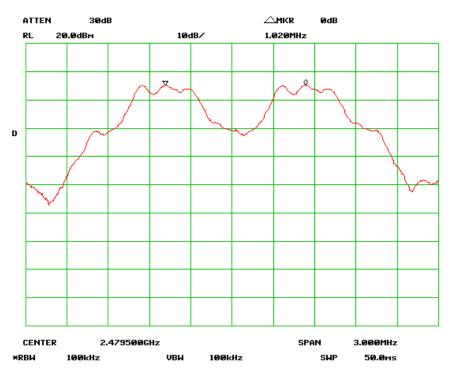


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Channel Separation – Mid Channel



Channel Separation – High Channel



Serial#: Issue Date: 8 November 2010

5.4 20dB Bandwidth & 99% Occupied Bandwidth

1. Conducted Measurement

EUT was set for low, mid, high channel with modulated mode and highest RF output power.

The spectrum analyzer was connected to the antenna terminal.

Environmental Conditions 25°C 2. Temperature Relative Humidity 50%

Atmospheric Pressure 1019mbar

Conducted Emissions Measurement Uncertainty 3.

> All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are

normal), with a coverage factor of 2, in the range 30MHz – 40GHz is ±1.5dB.

Test date: 28 October to 5 November 2010 4.

Tested By: Peter Cai

Requirement(s): Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125mW.

Procedures: The 20dB bandwidths were measured conducted using a spectrum analyzer at low, mid, and hi channels.

Configuration: Bluetooth Mode, Basic Rate

Channel	Channel Frequency (MHz)	20 dB Channel Bandwidth (MHz)	2/3 20dB Bandwidth (MHz)	Limit (MHz)	99% Channel Bandwidth (MHz)
Low	2402	1.100	0.733	1	0.950
Mid	2441	1.120	0.747	1	0.955
High	2480	1.102	0.735	1	0.955

Configuration: Bluetooth Mode, EDR

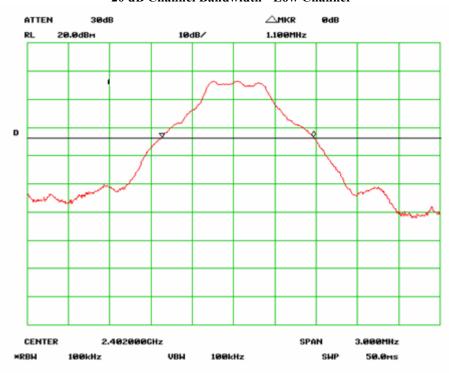
Channel	Channel Frequency (MHz)	20 dB Channel Bandwidth (MHz)	2/3 20dB Bandwidth (MHz)	Limit (MHz)	99% Channel Bandwidth (MHz)
Low	2402	1.135	0.757	1	1.000
Mid	2441	1.135	0.757	1	1.010
High	2480	1.135	0.757	1	1.005

Refer to the attached plots.

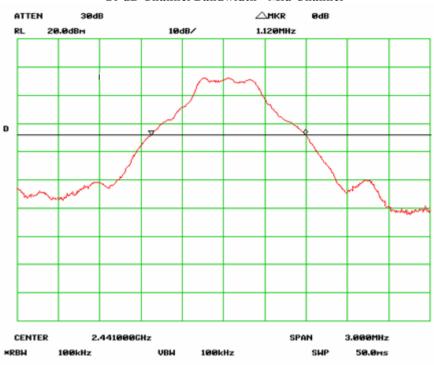
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Configuration: Bluetooth Mode, Basic Rate

20 dB Channel Bandwidth - Low Channel

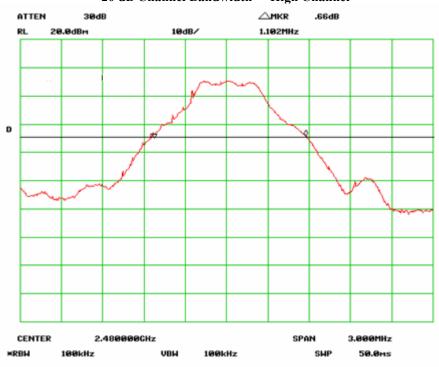


20 dB Channel Bandwidth - Mid Channel



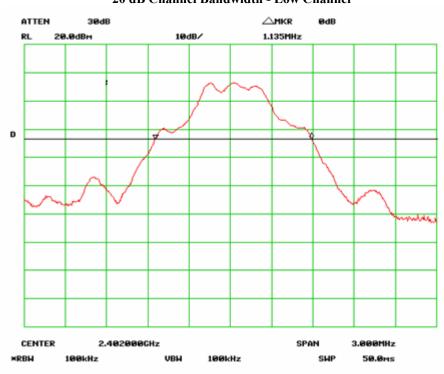
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20 dB Channel Bandwidth - High Channel



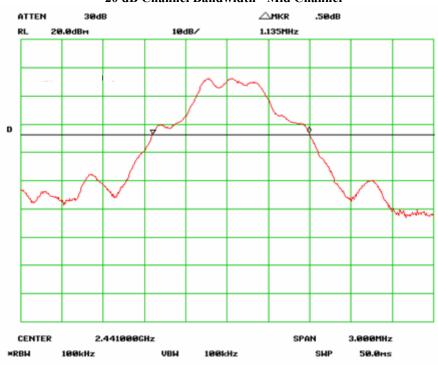
Configuration: Bluetooth Mode, EDR

20 dB Channel Bandwidth - Low Channel

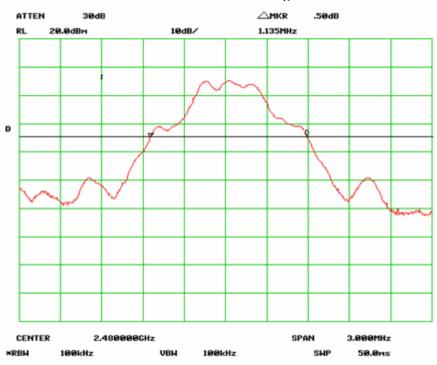


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20 dB Channel Bandwidth - Mid Channel



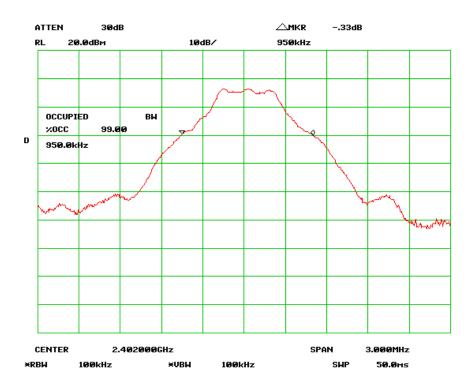
20 dB Channel Bandwidth - High Channel



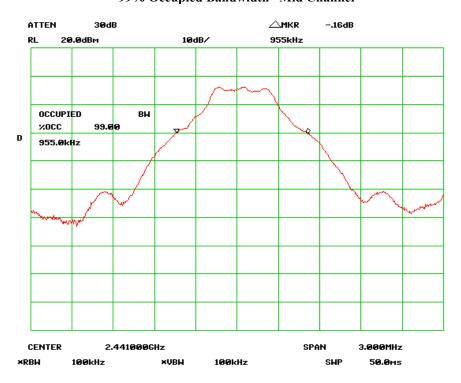
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Configuration: Bluetooth Mode, Basic Rate

99% Occupied Bandwidth - Low Channel

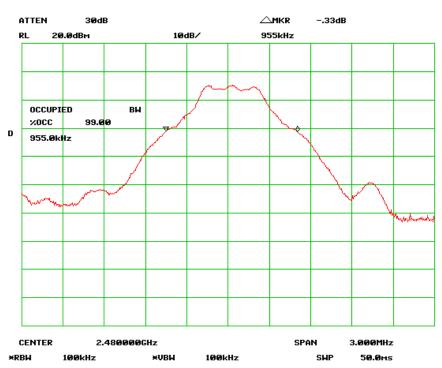


99% Occupied Bandwidth - Mid Channel



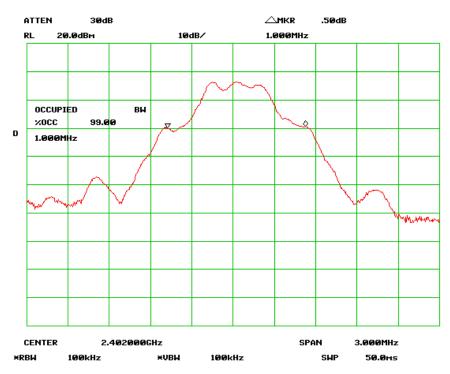
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99% Occupied Bandwidth - High Channel



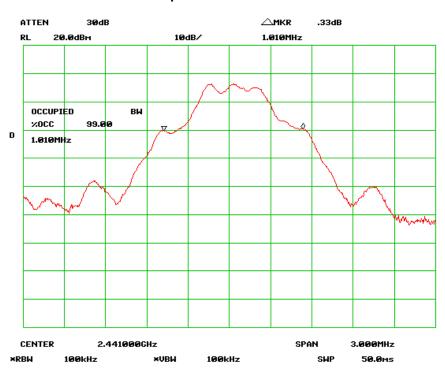
Configuration: Bluetooth Mode, EDR

99% Occupied Bandwidth -Low Channel

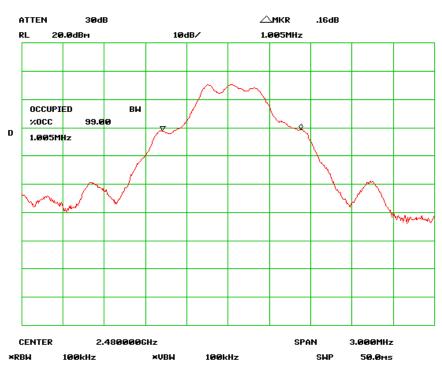


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99% Occupied Bandwidth - Mid Channel



99% Occupied Bandwidth - High Channel



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5.5 Number of Hopping Channel

1. Conducted Measurement

EUT was set for low, mid, high channel with modulated mode and highest RF output power.

The spectrum analyzer was connected to the antenna terminal.

2. Conducted Emissions Measurement Uncertainty

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz – 40GHz is ±1.5dB.

3. Environmental Conditions

Temperature 25°C Relative Humidity 50%

Atmospheric Pressure 1019mbar

4. Test date: 28 October to 5 November 2010

Tested By: Peter Cai

Standard Requirement:

Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels.

Procedures: The Number of Hopping Channel measurement was taken conducted using a spectrum analyzer.

RBW=100 KHz, VBW > RBW

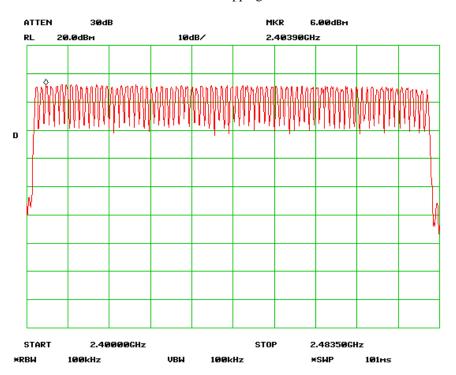
Test Result:

Total Channel: 79 Channels

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Configuration: Bluetooth Mode, Basic Rate

Number of Hopping Channel



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5.6 Time of Occupancy

1. Conducted Measurement

EUT was set for low, mid, high channel with modulated mode and highest RF output power.

The spectrum analyzer was connected to the antenna terminal.

2. Conducted Emissions Measurement Uncertainty

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal) with a coverage factor of 2 in the range 30MHz = 40GHz is ±1.5dB

normal), with a coverage factor of 2, in the range 30MHz - 40GHz is $\pm 1.5dB$. 3. Environmental Conditions Temperature $25^{\circ}C$

Relative Humidity 50%

Atmospheric Pressure 1019mbar

4. Test date: 28 October to 5 November 2010

Tested By: Peter Cai

Standard Requirement:

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used

Procedures: The Time of Occupancy measurement was taken conducted using a spectrum analyzer.

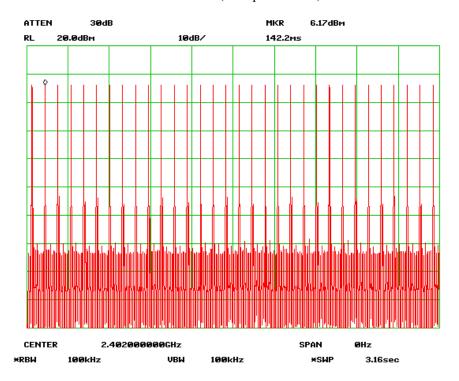
Test Result:

Channel	Channel Frequency (MHz)	Dwell Time (sec)	Limit (sec)
Low	2402	0.16	0.4
Mid	2441	0.16	0.4
High	2480	0.16	0.4

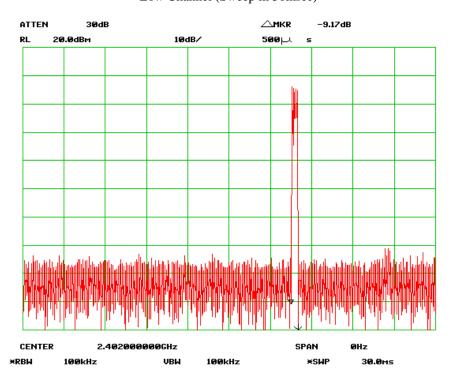
Note: *Dwell Time* = On-time * number of times the specific channel on during 31.6sec sweep.

Configuration: Bluetooth Mode, Basic Rate

Low Channel (Sweep in 3.16sec)

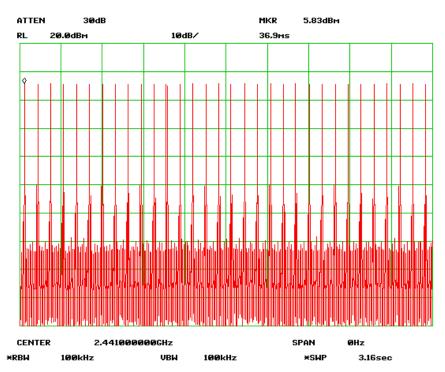


Low Channel (Sweep in 30msec)

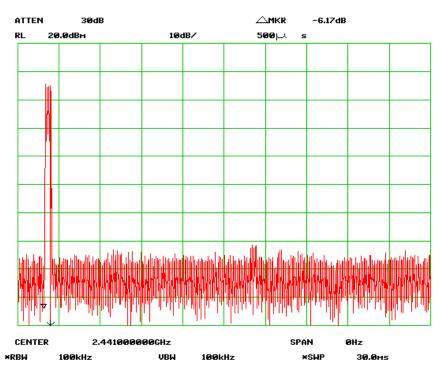


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Mid Channel (Sweep in 3.16sec)

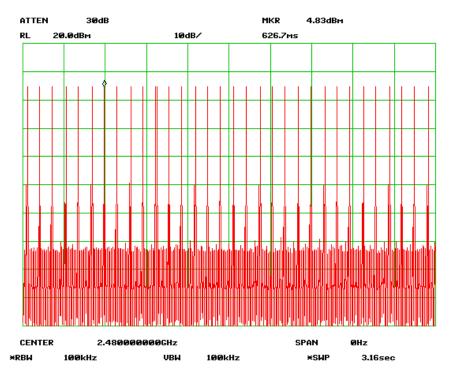


Mid Channel (Sweep in 30msec)

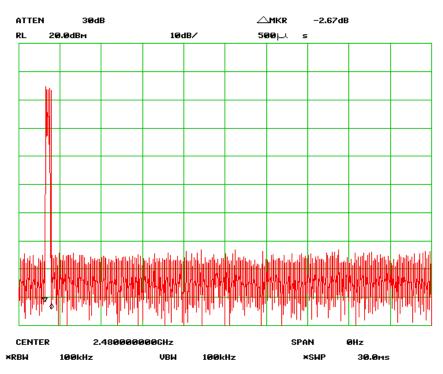


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High Channel (Sweep in 3.16sec)



High Channel (Sweep in 30msec)



Serial#:

Issue Date: 8 November 2010

5.7 Peak Output Power

Conducted Measurement

EUT was set for low, mid, high channel with modulated mode and highest RF output power.

The spectrum analyzer was connected to the antenna terminal.

Conducted Emissions Measurement Uncertainty 2.

> All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz – 40GHz is ±1.5dB.

Environmental Conditions 3.

Temperature Relative Humidity 50%

Atmospheric Pressure 1019mbar

Test date: 28 October to 5 November 2010 4.

Tested By: Peter Cai

Standard Requirement:

For frequency hopping systems in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt.For all other frequency hopping systems in the 2400-2483.5MHz band: 0.125 watts.

Procedures:

The peak output power was measured conducted using a spectrum analyzer at low, mid, and hi channels. Peak detector was set to measure the power output. The power is converted from watt to dBm, therefore, 1 watt = 30 dBm.

Test Result:

Configuration: Bluetooth Mode, Basic Rate

Channel	Channel Frequency (MHz)	Measured Output Power (dBm)	Peak Output Power Limit (dBm)
Low	2402	6.67	30
Mid	2441	6.33	30
High	2480	5.50	30

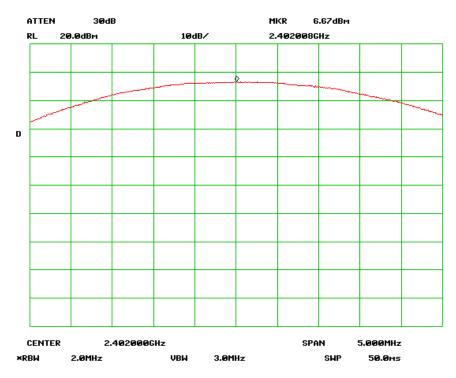
Configuration: Bluetooth Mode, EDR

Channel	Channel Frequency (MHz)	Measured Output Power (dBm)	Peak Output Power Limit (dBm)
Low	2402	6.50	30
Mid	2441	6.17	30
High	2480	5.33	30

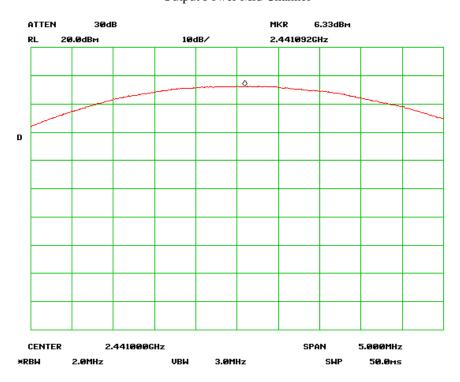
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Configuration: Bluetooth Mode, Basic Rate

Output Power Low Channel

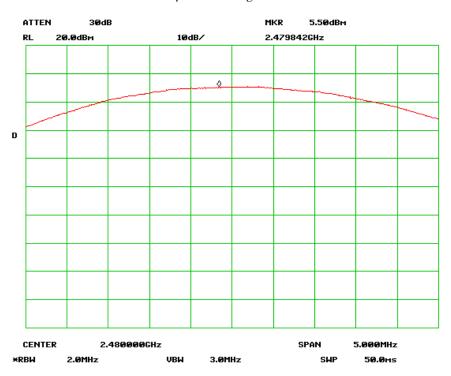


Output Power Mid Channel



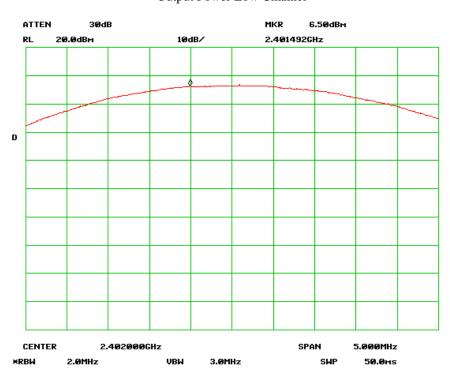
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Output Power High Channel



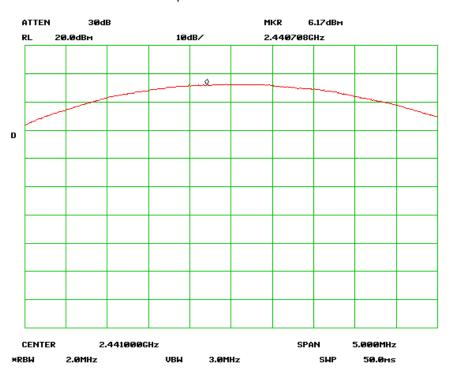
Configuration: Bluetooth Mode, EDR

Output Power Low Channel

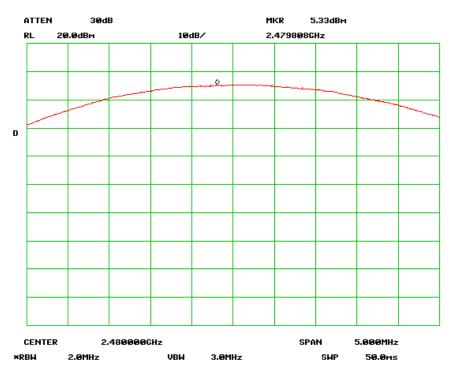


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Output Power Mid Channel



Output Power High Channel



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5.8 Antenna Port Emission

1. <u>Conducted Measurement</u>

EUT was set for low, mid, high channel with modulated mode and highest RF output power.

The spectrum analyzer was connected to the antenna terminal.

2. <u>Conducted Emissions Measurement Uncertainty</u>

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are

normal), with a coverage factor of 2, in the range 30MHz - 40GHz is ±1.5dB.

3. Environmental Conditions Temperature 25°C

Relative Humidity 50% Atmospheric Pressure 1019mbar

Atmospheric Pressure 10
4. Test date: 28 October to 5 November 2010

Tested By : Peter Cai

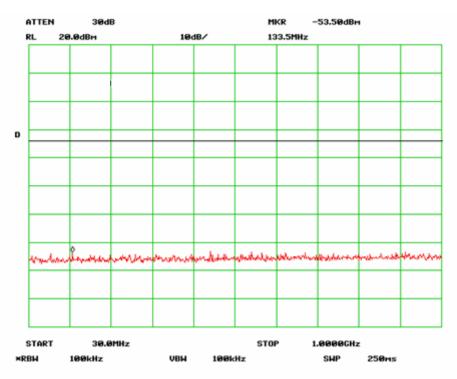
Standard Requirement: Radiated emission limits: In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the modulation products of the spreading sequence, the information sequence and the carrier frequency shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power

Procedures: The conducted spurious emissions were measured conducted using a spectrum analyzer at low, mid, and hi channels. The limit was determined by attenuating 20 dB of the RF peak power output

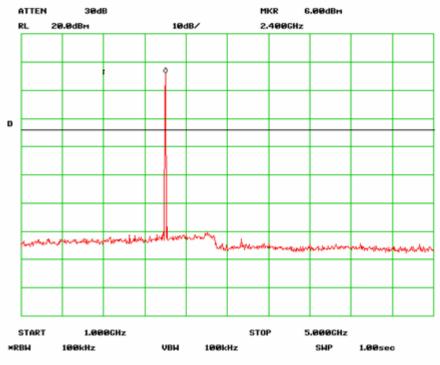
Test Result:

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Configuration: Bluetooth Mode, Basic Rate

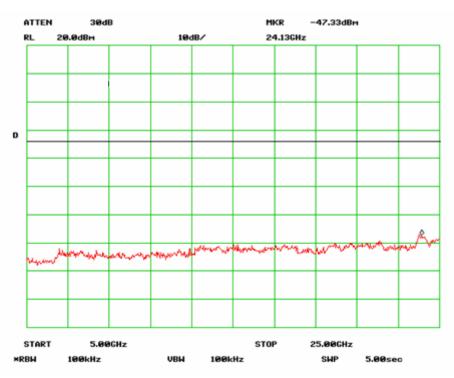


Antenna Port Emission Low-1

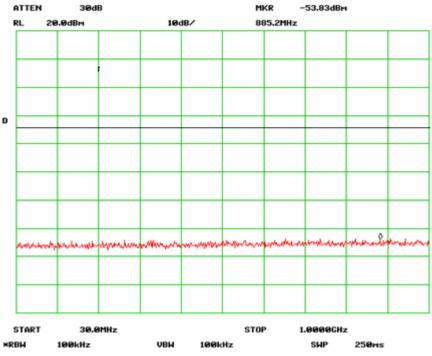


Antenna Port Emission Low-2

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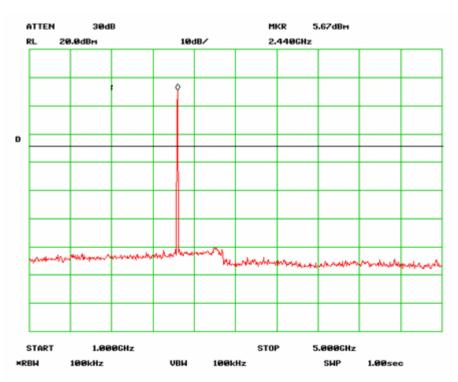


Antenna Port Emission Low-3

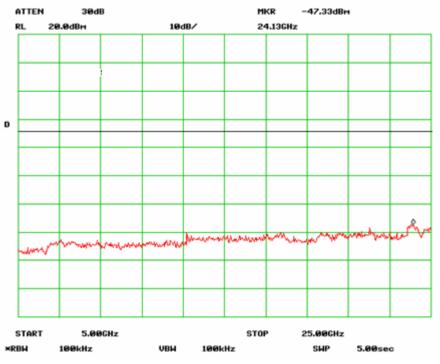


Antenna Port Emission Mid-1

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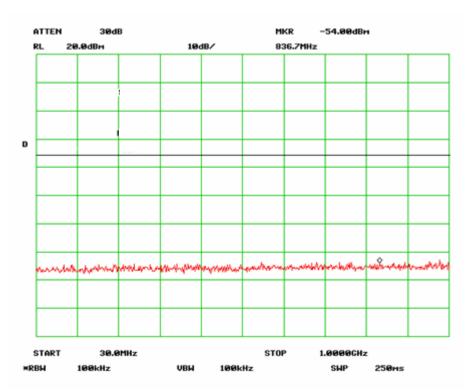


Antenna Port Emission Mid-2

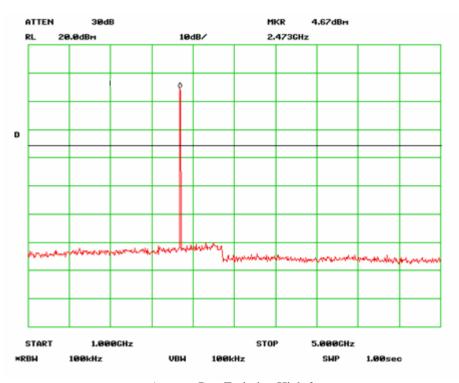


Antenna Port Emission Mid-3

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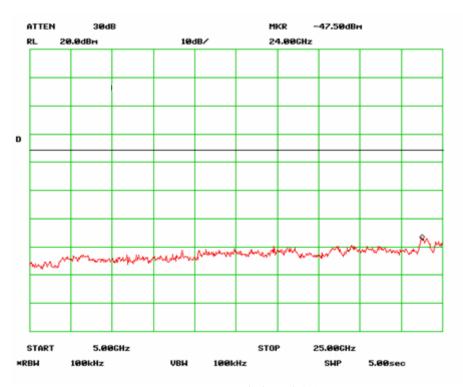


Antenna Port Emission High-1



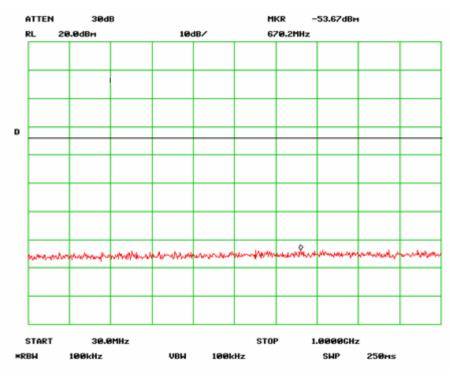
Antenna Port Emission High-2

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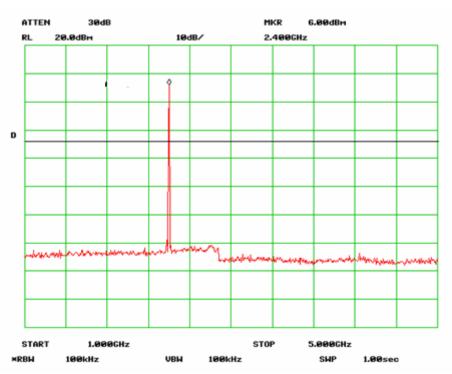
Antenna Port Emission High-3

Configuration: Bluetooth Mode, EDR

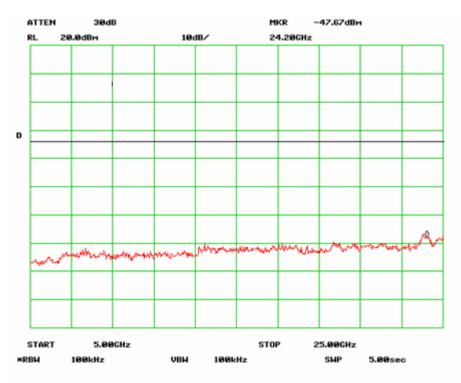


Antenna Port Emission Low-1

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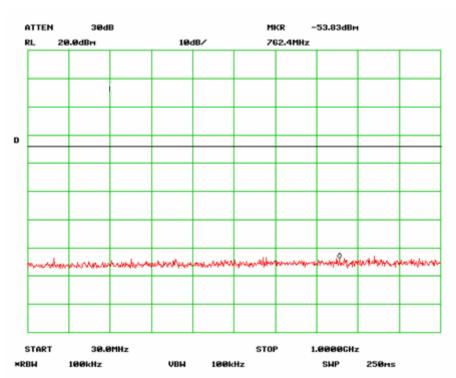


Antenna Port Emission Low-2

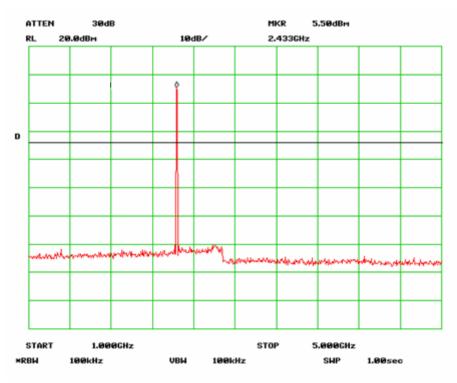


Antenna Port Emission Low-3

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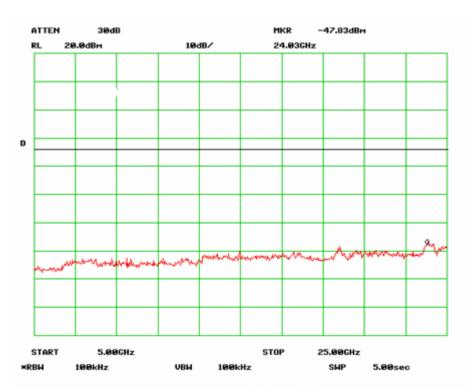


Antenna Port Emission Mid-1

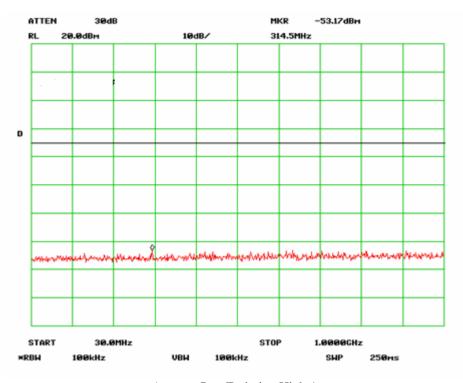


Antenna Port Emission Mid-2

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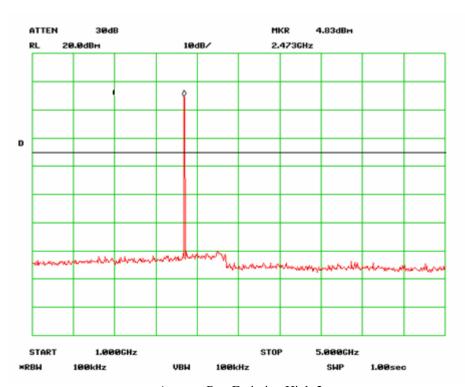


Antenna Port Emission Mid-3

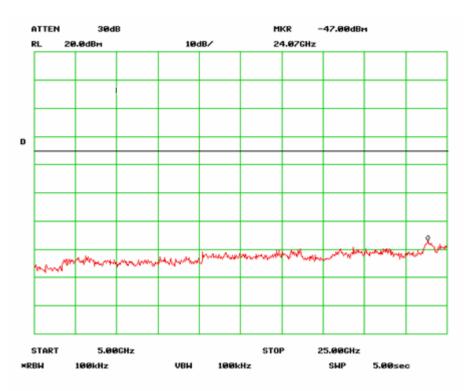


Antenna Port Emission High-1

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Antenna Port Emission High-2



Antenna Port Emission High-3

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5.9 Radiated Spurious Emission < 1GHz

- 1. <u>All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported.</u> All other emissions were relatively insignificant.
- 2. <u>A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.</u>
- 3. Radiated Emissions Measurement Uncertainty

All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz – 1GHz & 1GHz above (3m & 10m) is +/-6dB.

4. Environmental Conditions

Temperature 25°C Relative Humidity 50%

Atmospheric Pressure 1019mbar

5. Test date: 28 October to 5 November 2010

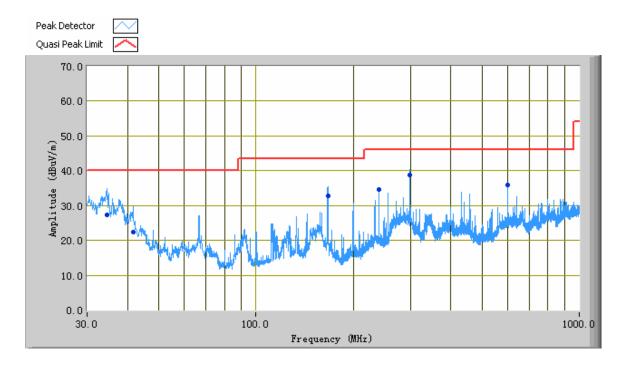
Tested By: Peter Cai

Standard Requirement: The emissions from the Low-power radio-frequency devices shall not exceed the field strength levels specified in the following table and the level of any unwanted emissions shall not exceed the level of the fundamental emission. The tighter limit applies at the band edges.

Test Result:

Note: Other Bluetooth modes were verified, only the result of worst case basic rate mode was presented.

Transmit mode

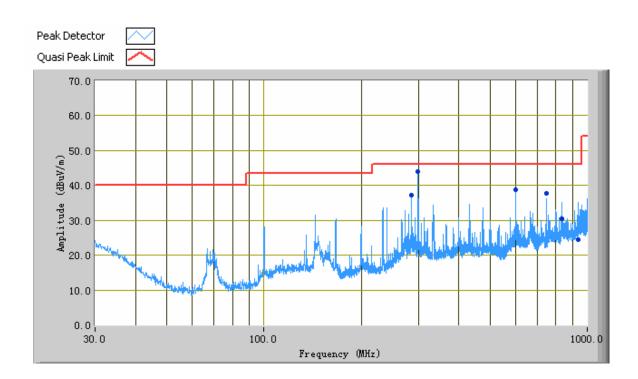


Test Data

1 csi Duiu								
Frequency (MHz)	Quasi Peak (dBuV/m)	Azimuth	Polarity(H /V)	Height (cm)	Factors (dB)	Limit (dBuV/m)	Margin (dB)	
34.55	27.36	255.00	V	136.00	-26.35	40.00	-12.64	
299.49	38.75	16.00	V	107.00	-31.31	46.00	-7.25	
166.95	32.74	223.00	V	102.00	-32.62	43.50	-10.76	
41.51	22.51	358.00	V	108.00	-31.33	40.00	-17.49	
599.97	36.00	82.00	V	105.00	-25.02	46.00	-10.00	
240.01	34.48	262.00	V	101.00	-31.71	46.00	-11.52	



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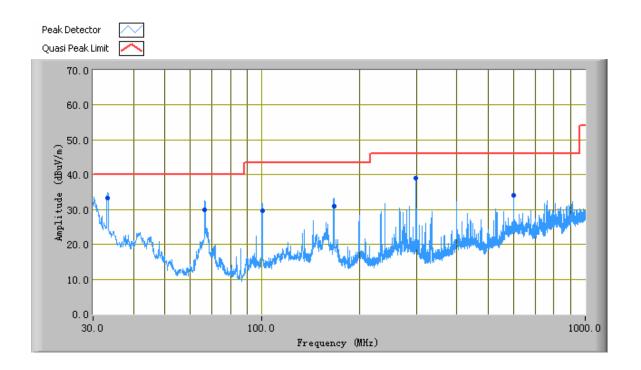
Test Data

Frequency (MHz)	Quasi Peak (dBuV/m)	Azimuth	Polarity(H /V)	Height (cm)	Factors (dB)	Limit (dBuV/m)	Margin (dB)
299.49	43.96	120.00	Н	158.00	-28.73	46.00	-2.04
599.99	38.73	51.00	Н	109.00	-25.52	46.00	-7.27
286.31	37.25	117.00	Н	144.00	-28.43	46.00	-8.75
748.74	37.74	51.00	Н	155.00	-23.42	46.00	-8.26
939.46	24.36	57.00	Н	131.00	-20.90	46.00	-21.64
834.28	30.51	0.00	Н	198.00	-19.90	46.00	-15.49



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Receive mode

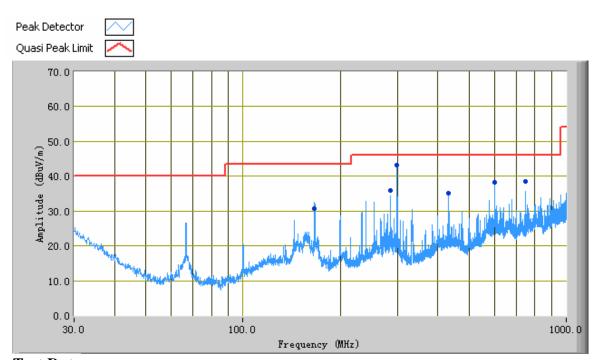


Test Data

Frequency (MHz)	Quasi Peak (dBuV/m)	Azimuth	Polarity(H /V)	Height (cm)	Factors (dB)	Limit (dBuV/m)	Margin (dB)
33.38	33.21	308.00	V	103.00	-25.35	40.00	-6.79
299.47	39.14	132.00	V	100.00	-31.31	46.00	-6.86
66.59	29.90	10.00	V	167.00	-38.76	40.00	-10.10
166.76	31.06	197.00	V	105.00	-32.60	43.50	-12.44
600.00	34.14	53.00	V	221.00	-25.02	46.00	-11.86
100.15	29.73	356.00	V	109.00	-34.67	43.50	-13.77



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Test Data

Frequency (MHz)	Quasi Peak (dBuV/m)	Azimuth	Polarity(H /V)	Height (cm)	Factors (dB)	Limit (dBuV/m)	Margin (dB)
299.49	43.26	111.00	Н	242.00	-31.31	46.00	-2.74
599.97	38.31	52.00	Н	222.00	-25.02	46.00	-7.69
748.73	38.60	45.00	Н	175.00	-22.81	46.00	-7.40
432.06	35.18	257.00	Н	106.00	-29.08	46.00	-10.82
166.68	30.69	290.00	Н	238.00	-32.59	43.50	-12.81
286.29	35.78	112.00	Н	155.00	-30.76	46.00	-10.22

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5.10 Radiated Spurious Emissions > 1GHz & Band Edge

- 1. <u>All possible modes of operation were investigated. Only the 6 worst case emissions measured, using the correct CISPR detectors, are reported. All other emissions were relatively insignificant.</u>
- 2. A "-ve" margin indicates a PASS as it refers to the margin present below the limit line at the particular frequency.
- 3. Radiated Emissions Measurement Uncertainty
 All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz 1GHz & 1GHz above (3m & 10m) is +/-6dB.

4. Environmental Conditions Temperature 25°C Relative Humidity 50%

Atmospheric Pressure 1019mbar

5. Test date: 28 October to 5 November 2010

Tested By: Peter Cai

Standard Requirement: The emissions from the Low-power radio-frequency devices shall not exceed the field strength levels specified in the following table and the level of any unwanted emissions shall not exceed the level of the fundamental emission. The tighter limit applies at the band edges.

Test Result:

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Note: Other Bluetooth modes were verified, only the result of worst case basic rate mode was presented.

Transmit mode

@ 2402MHz @ 3 Meter

Frequency	Direction	Height	Polar	Cable loss	Amplifier	Corrected Reading	15.247/15.209	15.247/15.209	
GHz	Degree	Meter	H/V	(dB)	(dB)	(dBuV/m)	Limit (dBuV/m)	Margin	Comments
4.804	15	1.11	٧	5.15	55.00	63.54	74.00	-10.46	Peak
4.804	21	1.09	h	5.15	55.00	61.96	74.00	-12.04	Peak
4.804	15	1.11	V	5.15	55.00	51.88	54.00	-2.12	Ave
4.804	21	1.09	h	5.15	55.00	50.93	54.00	-3.07	Ave

Emission was scanned up to 25GHz.

@ 2441MHz @ 3Meter

Frequency	Direction	Height	Polar	Cable loss	Amplifier	Corrected Reading	15.247/15.209	15.247/15.209	
GHz	Degree	Meter	H/V	(dB)	(dB)	(dBuV/m)	Limit (dBuV/m)	Margin	Comments
4.882	0	1.25	٧	5.16	55.00	62.85	74.00	-11.15	Peak
4.882	13	1.38	h	5.16	55.00	63.67	74.00	-10.33	Peak
4.882	0	1.25	٧	5.16	55.00	50.44	54.00	-3.56	Ave
4.882	13	1.38	h	5.16	55.00	51.09	54.00	-2.91	Ave

Emission was scanned up to 25GHz.

@ 2480MHz @ 3Meter

						0			
Frequency	Direction	Height	Polar	Cable loss	Amplifier	Corrected Reading	15.247/15.209	15.247/15.209	
GHz	Degree	Meter	H/V	(dB)	(dB)	(dBuV/m)	Limit (dBuV/m)	Margin	Comments
4.960	24	1.52	٧	5.17	55.00	61.28	74.00	-12.72	Peak
4.960	5	1.34	h	5.17	55.00	62.30	74.00	-11.70	Peak
4.960	24	1.52	٧	5.17	55.00	49.54	54.00	-4.46	Ave
4.960	5	1.34	h	5.17	55.00	50.08	54.00	-3.92	Ave

Emission was scanned up to 25GHz.

Receive mode

Harmonic above 1GHz is very low, so there is no test data presented in the report.



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Band Edge

Channel	Polarity	Detector	Frequency	Result	Limit	Margin
Low Channel	V	Peak	2400	39.61	74	-34.39
Low Channel	Н	Peak	2400	35.80	74	-38.20
Low Channel	V	Avg	2400	28.64	54	-25.36
Low Channel	Н	Avg	2400	27.92	54	-26.08

Channel	Polarity	Detector	Frequency	Result	Limit	Margin
High Channel	V	Peak	2483.5	38.86	74	-35.14
High Channel	Н	Peak	2483.5	37.34	74	-36.66
High Channel	V	Avg	2483.5	26.66	54	-27.34
High Channel	Н	Avg	2483.5	26.51	54	-27.49



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Annex A. TEST INSTRUMENT & METHOD

Annex A.i. TEST INSTRUMENTATION & GENERAL PROCEDURES

Instrument	Manufacturer	Model	CAL Due Date
Spectrum Analyzer	HP	8564 E	2011.04.01
EMI Receiver	Rohde & Schwarz	ESPI 3	2011.02.19
Antenna (30MHz~2GHz)	Sunol Sciences	JB1	2011.10.04
Horn Antenna (1~18GHz)	A-INFOMW	JXTXLB-10180	2010.11.18
Horn Antenna (1~18GHz)	ETS-Lindgren	3115	2011.10.04
Pre-Amplifier(0.01 ~ 1.3GHz)	HP	8447F	2011.04.01
Pre-Amplifier(0.1 ~ 18GHz)	MITEQ	AMF-7D-00101800-30- 10P	2011.10.05
Horn Antenna (18~40GHz)	Com Power	AH-840	2011.05.21
Microwave Pre-Amp (18~40GHz)	Com Power	PA-840	2011.05.21

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Annex A.ii. CONDUCTED EMISSIONS TEST DESCRIPTION

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m x 1m x 0.8m high, non-metallic table, as shown in Annex B.
- 2. The power supply for the EUT was fed through a $50\Omega/50\mu H$ EUT LISN, connected to filtered mains.
- The RF OUT of the EUT LISN was connected to the EMI test receiver via a low-loss coaxial cable.
- 4. All other supporting equipments were powered separately from another main supply.

Test Method

- 1. The EUT was switched on and allowed to warm up to its normal operating condition.
- 2. A scan was made on the NEUTRAL line (for AC mains) or Earth line (for DC power) over the required frequency range using an EMI test receiver.
- 3. High peaks, relative to the limit line, were then selected.
- 4. The EMI test receiver was then tuned to the selected frequencies and the necessary measurements made with a receiver bandwidth setting of 10 KHz. For FCC tests, only Quasi-peak measurements were made; while for CISPR/EN tests, both Quasi-peak and Average measurements were made.
- 5. Steps 2 to 4 were then repeated for the LIVE line (for AC mains) or DC line (for DC power).

Sample Calculation Example

At 20 MHz $limit = 250 \mu V = 47.96 dB\mu V$

Transducer factor of LISN, pulse limiter & cable loss at 20 MHz = 11.20 dB

Q-P reading obtained directly from EMI Receiver = $40.00 \text{ dB}_{\mu}\text{V}$ (Calibrated for system losses)

Therefore, Q-P margin = 47.96 - 40.00 = 7.96 i.e. **7.96 dB below limit**

Annex A. iii. RADIATED EMISSIONS TEST DESCRIPTION

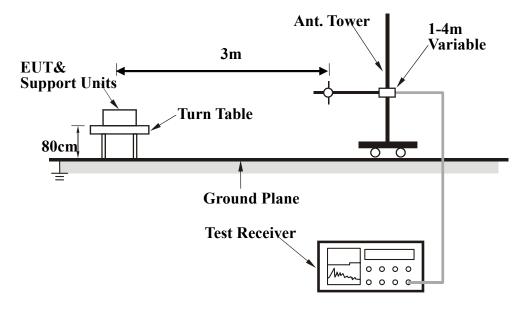
EUT Characterisation

EUT characterisation, over the frequency range from 30MHz to 10th Harmonic , was done in order to minimise radiated emissions testing time while still maintaining high confidence in the test results.

The EUT was placed in the chamber, at a height of about 0.8m on a turntable. Its radiated emissions frequency profile was observed, using a spectrum analyzer /receiver with the appropriate broadband antenna placed 3m away from the EUT. Radiated emissions from the EUT were maximised by rotating the turntable manually, changing the antenna polarisation and manipulating the EUT cables while observing the frequency profile on the spectrum analyzer / receiver. Frequency points at which maximum emissions occurred, clock frequencies and operating frequencies were then noted for the formal radiated emissions test at the Open Area Test Site (OATS).

Test Set-up

- 1. The EUT and supporting equipment were set up in accordance with the requirements of the standard on top of a 1.5m X 1.0m X 0.8m high, non-metallic table.
- 2. The filtered power supply for the EUT and supporting equipment were tapped from the appropriate power sockets located on the turntable.
- 3. The relevant broadband antenna was set at the required test distance away from the EUT and supporting equipment boundary.



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Test Method

The following procedure was performed to determine the maximum emission axis of EUT:

- 1. With the receiving antenna is H polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
- 2. With the receiving antenna is V polarization, rotate the EUT in turns with three orthogonal axes to determine the axis of maximum emission.
- 3. Compare the results derived from above two steps. So, the axis of maximum emission from EUT was determined and the configuration was used to perform the final measurement.

Final Radiated Emission Measurement

- 1. Setup the configuration according to figure 1. Turn on EUT and make sure that it is in normal function.
- 2. For emission frequencies measured below 1 GHz, a pre-scan is performed in a shielded chamber to determine the accurate frequencies of higher emissions will be checked on a open test site. As the same purpose, for emission frequencies measured above 1 GHz, a pre-scan also be performed with a 1 meter measuring distance before final test.
- 3. For emission frequencies measured below and above 1 GHz, set the spectrum analyzer on a 100 kHz and 1 MHz resolution bandwidth respectively for each frequency measured in step 2.
- 4. The search antenna is to be raised and lowered over a range from 1 to 4 meters in horizontally polarized orientation. Position the highness when the highest value is indicated on spectrum analyzer, then change the orientation of EUT on test table over a range from $0 \circ to 360 \circ with a speed as slow as possible, and keep the azimuth that highest emission is indicated on the spectrum analyzer. Vary the antenna position again and record the highest value as a final reading.$
- 5. Repeat step 4 until all frequencies need to be measured were complete.
- 6. Repeat step 5 with search antenna in vertical polarized orientations.

During the radiated emission test, the Spectrum Analyzer was set with the following configurations:

Frequency Band (MHz)	Function	Resolution bandwidth	Video Bandwidth
30 to 1000	Peak	100 kHz	100 kHz
Above 1000	Peak	1 MHz	1 MHz
Above 1000	Average	1 MHz	10 Hz

Sample Calculation Example

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. For the limit is employed average value, therefore the peak value can be transferred to average value by subtracting the duty factor. The basic equation with a sample calculation is as follows:

Peak = Reading + Corrected Factor

where

Corr. Factor = Antenna Factor + Cable Factor - Amplifier Gain (if any) And the average value is

Average = Peak Value + Duty Factor or Set RBW = 1MHz, VBW = 10Hz.

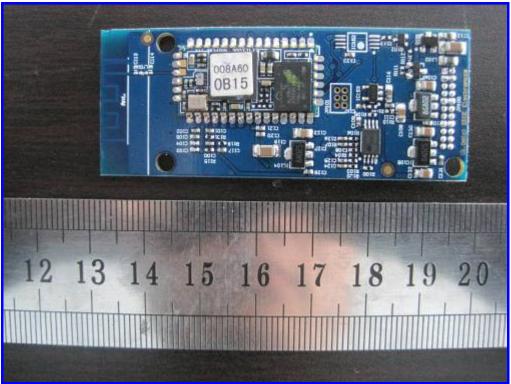
Note:

If the measured frequencies are fall in the restricted frequency band, the limit employed must be quasi peak value when frequencies are below or equal to 1 GHz. And the measuring instrument is set to quasi peak detector function.

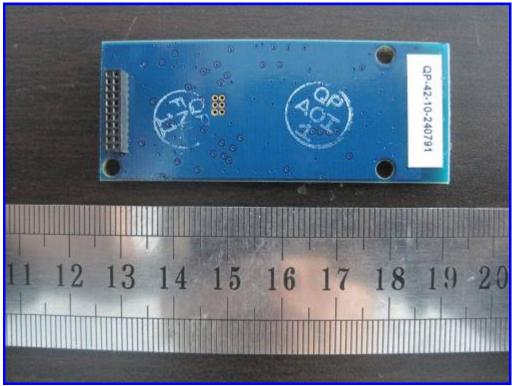
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Annex B. EUT AND TEST SETUP PHOTOGRAPHS

Annex B.i. Photograph: EUT Photo

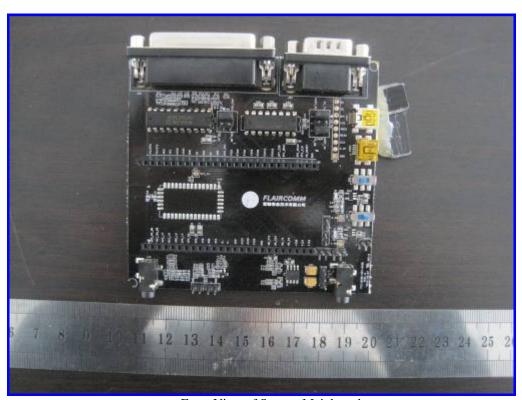


Front View of EUT

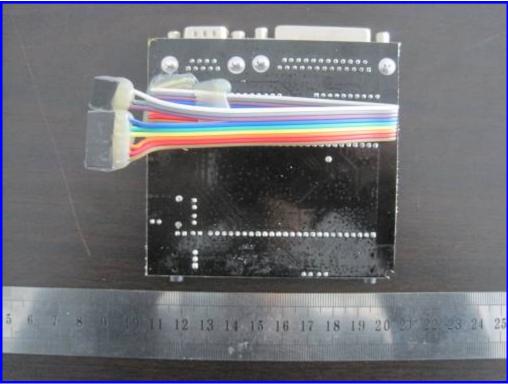


Rear View of EUT

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Front View of System Mainboard



Rear View of System Mainboard

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Front View of Communication Cable

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Annex B.ii. Photograph: Test Setup Photo



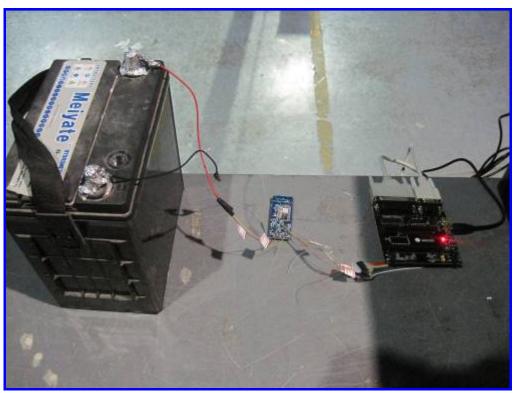
Front View of Radiated Emission Test Setup below 1GHz



Front View of Radiated Emission Test Setup above 1GHz



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Closed View of Radiated Emission Test Setup

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Annex C. TEST SETUP AND SUPPORTING EQUIPMENT

EUT TEST CONDITIONS

Annex C. i. SUPPORTING EQUIPMENT DESCRIPTION

The following is a description of supporting equipment and details of cables used with the EUT.

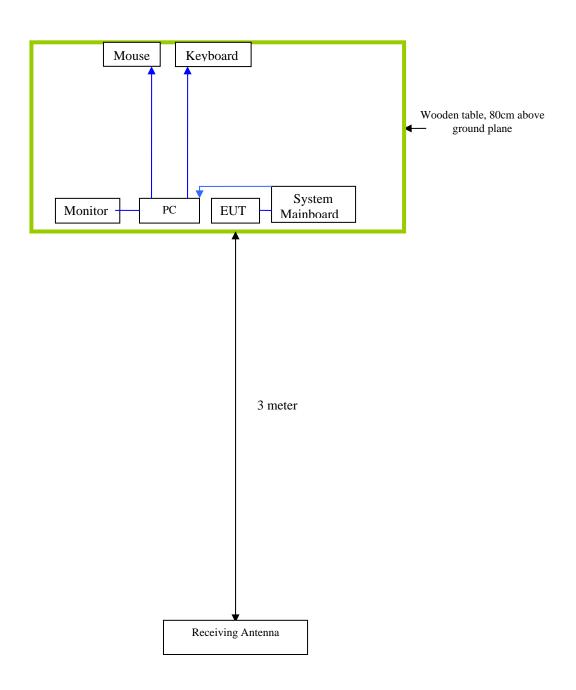
Equipment Description (Including Brand Name)	Model & Serial Number	Cable Description (List Length, Type & Purpose)
PC	Lenove & N/A	N/A
PHILIPS Monitor	HNS7170T& AU3A0721034997	N/A
Dell Keyboard	SK-8115 & N/A	N/A
Dell Mouse	MOC5UO & H0S00A91	N/A
System Mainboard	N/A	N/A

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Block Configuration Diagram for Conducted Emissions

N/A

Block Configuration Diagram for Radiated Emissions





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Annex C.ii. EUT OPERATING CONDITIONS

The following is the description of how the EUT is exercised during testing.

Test	Description Of Operation
Emissions Testing	The EUT was continuously transmitting to stimulate the worst case.



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Annex D. USER MANUAL / BLOCK DIAGRAM / SCHEMATICS / PART LIST Please see attachment

Serial#:

Issue Date: 8 November 2010

Annex E. SIEMIC ACCREDITATION CERTIFICATES

SIEMIC ACREDITATION DETAILS: A2LA Certificate Number: 2742.01



The American Association for Laboratory Accreditation

Accredited Laboratory

A2LA has accredited

SIEMIC LABORATORIES

San Jose, CA for technical competence in the field of

Electrical Testing

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated 8 January 2009).



Presented this 11th day of July 2008.

President & CEO For the Accreditation Council Certificate Number 2742.01

Valid to December 31, 2010

For the tests or types of tests to which this accreditation applies, please refer to the laboratory's Electrical Scope of Accreditation



The American Association for Laboratory Accreditation

Accredited Product Certification Body

A2LA has accredited

SIEMIC LABORATORIES

San Jose, CA for technical competence as a

Product Certification Body

This product certification body is accredited in accordance with the recognized International Standard ISO/IEC Guide 65:1996 General requirements for bodies operating product certification systems. This accreditation demonstrates technical competence for a defined scope and the operation of a quality management system for a Telecommunications Certification Body (TCB) meeting FCC (U.S.), IDA (Singapore), IC (Canada) and OFTA Hong Kong requirements.

Presented this 9th day of January 2009.

Peter Albrye President & CEO

For the Accreditation Council Certificate Number 2742.02 Valid to December 31, 2010

Revised September 16, 2010

For the product certification schemes to which this accreditation applies, please refer to the organization's Product Certification Scope of Accreditation

Issue Date: 8 November 2010

SIEMIC ACCREDITATION DETAILS: FCC Registration NO:986914



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www.siemic.com.cn

SIEMIC ACCREDITATION DETAILS: FCC Listing, Registration NO:986914

FEDERAL COMMUNICATIONS COMMISSION

Laboratory Division 7435 Oakland Mills Road Columbia, MD 21046

April 25, 2008

Registration Number: 986914

SIEMIC Nanjing (China) Laboratories 2-1 Longcang Avenue, Yuhua Economic and Technology Development Park, Nanjing, 210039 China

Attention: Leslie Bai

Re: Measurement facility located at 2-1 Longcang Avenue, Nanjing, China

Anechoic chamber (3 meters) and 3&10 meter OATS

Date of Listing: April 25, 2008

Dear Sir or Madam:

Your request for registration of the subject measurement facility has been reviewed and found to be in compliance with the requirements of Section 2.948 of the FCC rules. The information has, therefore, been placed on file and the name of your organization added to the list of facilities whose measurement data will be accepted in conjunction with applications for Certification under Parts 15 or 18 of the Commission's Rules. Please note that the file must be updated for any changes made to the facility and the registration must be renewed at least every three years.

Measurement facilities that have indicated that they are available to the public to perform measurement services on a fee basis may be found on the FCC website www.fcc.gov under E-Filing, OET Equipment Authorization Electronic Filing, Test Firms.

Sincerely,

Katie Hawkins Electronics Engineer

Serial#: Issue Date: 8 November 2010

SIEMIC ACCREDITATION DETAILS: Industry of Canada Registration No. 4842

Industry Industric

February 19, 2009

OUR FILE: 46405-4842 Submission No: 131645

SIEMIC NANJING (CHINA) LABORATORIES

2-1 Longcang Avenue Yuhua Economic & Technology Dev. Park Nanjing China

Attention: Leslie Bai

Dear Sir/Madame:

The Bureau has received your application for the registration of a 3m/10m alternative test site. Be advised that the information received was satisfactory to Industry Canada. The following number(s) is now associated to the site(s) for which registration / renewal was sought (4842B-1). Please reference the appropriate site number in the body of test reports containing measurements performed on the site. In addition, please keep for your records the following information;

- Your primary code is: 4842
- The company number associated to the site(s) located at the above address is: 4842B

Furthermore, to obtain or renew a unique site number, the applicant shall demonstrate that the site has been accredited to ANSI C63.4-2003 or later. A scope of accreditation indicating the accreditation by a recognized accreditation body to ANSI C63.4-2003 shall be accepted. Please indicate in a letter the previous assigned site number if applicable and the type of site (example: 3 meter OATS or 3 meter chamber). If the test facility is not accredited to ANSI C63.4-2003 or later, the test facility shall submit test data demonstrating full compliance with the ANSI standard. The Bureau will evaluate the filing to determine if recognition shall be granted.

The frequency for re-validation of the test site and the information that is required to be filed or retained by the testing party shall comply with the requirements established by the accrediting organization. However, in all cases, test site re-validation shall occur on an interval not to exceed two years. There is no fee or form associated with an OATS filing. OATS submissions are encouraged to be submitted electronically to the Bureau using the following URL;

http://strategis.ic.gc.ca/epic/internet/inceb-bhst.nsf/en/h_tt00052e.html.

If you have any questions, you may contact the Bureau by e-mail at certification bureau@ic.gc.ca Please reference our file and submission number above for all correspondence.

Yours sincerely,

For: Wireless Laboratory Manager Certification and Engineering Bureau 3701 Carling Ave., Building 94 P.O. Box 11490, Station "H" Ottawa, Ontario K2H 8S2 Email: joshua.laviolette@ic.gc.ca

Tel. No. (613) 990-2681 Fax. No. (613) 990-4752



Serial#:

Issue Date: 8 November 2010

SIEMIC ACCREDITATION DETAILS: Korea CAB from NIST: US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

October 1, 2008

Mr. Leslie Bai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by the Radio Research Agency (RRA) Korea Communications Commission (KCC) under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name: SIEMIC, Inc.

2206 Ringwood Avenue, San Jose, CA 95131 Physical Location:

Identification No.: US0160

EMI: KCC Notice 2008-39, RRL Notice 2008-3: CA Procedures for EMI Recognized Scope:

KN22: Test Method for EMI

EMS: KCC Notice 2008-38, RRL Notice 2008-4: CA Procedures for EMS KN24, KN-61000-4-2, -4-3, -4-4, -4-5, -4-6, -4-8, -4-11: Test Method for EMS Wireless: RRL Notice 2008-26, RRL Notice 2008-2, RRL Notice 2008-10,

RRL Notice 2007-49, RRL Notice 2007-20, RRL Notice 2007-21,

RRL Notice 2007-80, RRL Notice 2004-68

Wired: President Notice 20664, RRL Notice 2007-30, RRL Notice 2008-7 with attachments 1, 3, 5, 6

President Notice 20664, RRL Notice 2008-7 with attachment 4

You may submit test data to RRA/KCC to verify that the equipment to be imported into Korea satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. If you have any questions please contact Ramona Saar at (301) 975-5521 or ramona.saar@nist.gov.

Sincerely,

David F. Alderman

Group Leader, Standards Coordination and Conformity Group

Standards Services Division

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Enclosure

cc: Ramona Saar

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SIEMIC ACCREDITATION DETAILS: Taiwan BSMI CAB Accreditation No. SL2-IN-E-1130R



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

May 3, 2006

Mr. Leslie Bai SIEMIC Laboratories 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

I am pleased to inform you that your laboratory has been recognized by the Chinese Taipei's Bureau of Standards, Metrology, and Inspection (BSMI) under the Asia Pacific Economic Cooperation (APEC) Mutual Recognition Arrangement (MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, **Phase I** Procedures, of the APEC Tel MRA. You may submit test data to BSMI to verify that the equipment to be imported into Chinese Taipei satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements. The pertinent designation information is as follows:

BSMI number: SL2-IN-E-1130R (Must be applied to the test reports)

U.S Identification No: US0160
 Scope of Designation: CNS 13438
 Authorized signatory: Mr. Leslie Bai

The names of all recognized CABs will be posted on the NIST website at http://ts.nist.gov/mra. If you have any questions, please contact Mr. Dhillon at 301-975-5521. We appreciate your continued interest in our international conformity assessment activities.

Sincerely,

David F. Alderman

Group Leader, Standards Coordination and Conformity Group

cc: Jogindar Dhillon

NIST

Serial#: Issue Date: 8 November 2010

SIEMIC ACCREDITATION DETAILS: Taiwan NCC CAB ID: US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

March 16, 2009

Mr. LeslieBai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by the National Communications Commission (NCC) for the requested scope expansion under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name:

SIEMIC, Inc.

Physical Location:

2206 Ringwood Avenue, San Jose, CA 95131

Identification No.:

US0160

Current Scope:

LP0002, PSTN01, ADSL01, ID0002, IS6100 and CNS 14336

Additional Scope: PLMN07

You may submit test data to NCC to verify that the equipment to be imported into China satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. If you have any questions please contact Ramona Saar at (301) 975-5521 or ramona.saar@nist.gov.

Sincerely,

David F. Alderman

Group Leader, Standards Coordination and Conformity Group

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Standards Services Division

Enclosure

cc: Ramona Saar



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SIEMIC ACCREDITATION DETAILS: Mexico NOM Recognition



Laboratorio Valentín V. Rivero

México D.F. a 16 de octubre de 2006.

LESLIE BAI DIRECTOR OF CERTIFICATION SIEMIC LABORATORIES, INC. ACCESSING GLOBAL MARKETS PRESENTE

En contestación a su escrito de fecha 5 de septembre del año en curso, le comento que estamos muy interesados en su intención de firmar un Acuerdo de Reconocimiento Mutuo, para lo cual adjunto a este escrito encontrara el Acuerdo en idioma ingles y espeñol prellenado de los cuales le pido sea revisado y en su caso corregido, para que si esta de ecuerdo poder firmarlo para mandarto con las autoridades Mexicanas para su visto bueno y así poder ejercer dicho ecuerdo.

Aprovecho este escrito para mencionarie que nuestro intermediano gastor sará la empresa tastel de México. S. A. de C. V., empresa que ha colaborado durante mucho tiempo con nosotros en lo relacionado a la evaluación de la conformidad y que cuenta con amplia experiencia en la gestoria de la certificación de cumplimiento con Normas Oficiales Mexicanas de producto en México.

Me despido de ustad enviándole un cordial saludo y esperando sus comentarios al Acuerdo que nos poupa.

Atentamente:

Ing. Faustino Sortez Genzález Gerente-Terrico del Laboratorio de CAMEN.

Culturie 71 Handriene Condess Destro Maleon, D.F. Ter. 5294-0908 con 12 lineas Fas 1296-0918

Serial#:

Issue Date: 8 November 2010

SIEMIC ACCREDITATION DETAILS: Hong Kong OFTA Recognition No. D23/16V



Your Ref 來函檔號: Our Ref 本局檔號: D23/16 V

Telephone 電話: (852) 2961 6320 Fax No 圖文傳真: (852) 2838 5004

E-mail 電郵地址:

20 July 2005

Mr. Leslie Bai Director of Certification, SIEMIC Laboratories 2206 Ringwood Avenue San Jose, California 95131 USA

Dear Mr. Bai,

Application of Recognised Testing Agency (RTA)

Referring your submission of 28 June 2005 in relation to the application of RTA, I am pleased to inform you that OFTA has appointed SIEMIC Laboratories (SIEMIC) as a Recognised Testing Agency (RTA):

Please note that, under the Hong Kong Telecommunications Equipment Evaluation and Certification (HKTEC) Scheme, SIEMIC is authorized to conduct evaluation tests on telecommunications equipment against the following HKTA specifications:

Scope of recognition (HKTA Specifications):

1001, 1002, 1004, 1006, 1007, 1008

1010, 1015, 1016

1022, 1026, 1027, 1029

1030, 1031, 1032, 1033, 1034, 1035, 1039

1041, 1042, 1043, 1045, 1047, 1048

2001

You are requested to refer to and comply with the code of practice and guidelines for RTA as given in the Information Note OFTA I 411 "Recognised Testing Agency (RTA) for Conducting Evaluation Test of Telecommunications Equipment", which can be downloaded from OFTA's homepage http://www.ofta.gov.hk/tec/information-notes.html.

If you have any queries, please do not hesitate to contact me.

Yours sincerely,

(K K Sin)

for Director-General

of Telecommunications

Office of the Telecommunications Authority 29/F Wu Chung House 213 Queen's Road East Wan Chai Hong Kong http://www.ofta.gov.hk

電訊管理局

香港灣仔皇后大道東 213 號胡忠大廈 29 字樓

Serial#: Issue Date: 8 November 2010 Page:

SIEMIC ACCREDITATION DETAILS: OFTA CAB from NIST: US0160



UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

December 8, 2008

Mr. Leslie Bai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

Dear Mr. Bai:

NIST is pleased to inform you that your laboratory has been recognized by the Office of the Telecommunications Authority (OFTA) under the Asia Pacific Economic Cooperation for Telecommunications Equipment Mutual Recognition Arrangement (APEC Tel MRA). Your laboratory is now designated to act as a Conformity Assessment Body (CAB) under Appendix B, Phase I Procedures, of the APEC Tel MRA. The pertinent information about your laboratory's designation is as follows:

CAB Name:

SIEMIC, Inc.

Physical Location:

2206 Ringwood Avenue, San Jose, California 95131 USA

Identification No.:

Recognized Scope:

Radio: HKTA 1002, 1007, 1008, 1010, 1015, 1016, 1020, 1022, 1026, 1027, 1029, 1030, 1031, 1032, 1033, 1034, 1035, 1036, 1037, 1039, 1041,

1042, 1043, 1044, 1046, 1047, 1048, 1049, 1051

Telecom: HKTA 2011, 2012, 2013, 2014, 2017, 2018, 2022, 2024, 2026,

2027, 2028, 2029, 2030, 2031, 2032, 2033

You may submit test data to OFTA to verify that the equipment to be imported into Hong Kong satisfies the applicable requirements. The designation of your organization will remain in force as long as its accreditation for the designated scope remains valid and comply with the designation requirements.

Recognized CABs are listed on the NIST website at http://ts.nist.gov/mra. If you have any questions please contact Ramona Saar at (301) 975-5521 or ramona.saar@nist.gov.

Sincerely.

David F. Alderman

Group Leader, Standards Coordination and Conformity Group

Standards Services Division

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Enclosure

cc: Ramona Saar

 Serial#:
 1002743-FCC-IC

 Issue Date:
 8 November 2010

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www.siemic.com.cn

SIEMIC ACCREDITATION DETAILS: Australia NATA Recognition



Leslie Bai SIEMIC, Inc. 2206 Ringwood Avenue San Jose, CA 95131

November 4, 2008

Under Australian government legislation, the Australian Communications and Media Authority (ACMA) has determined the National Association of Testing Authorities, Australia (NATA) as an accreditation body as per Section 409(1) of the Telecommunications Act 1997 (Cth). Pursuant to Section 409(2) of the Telecommunications Act 1997 (Cth), I am pleased to advise that your laboratory has been determined as a Recognised Testing Authority (RTA).

This determination has been made on the basis of your accreditation by A2LA accreditation no. 2742.01 and the Mutual Recognition Agreement between NATA and A2LA. It is effective from 11 July 2008. RTA status applies only to the following standards and is contingent upon their continued inclusion in your laboratory's scope of accreditation.

AS/ACIF S002, AS/ACIF S003, AS/ACIF S004, AS/ACIF S006, AS/ACIF S016, AS/ACIF S031, AS/ACIF S038, AS/ACIF S041 and AS/ACIF S043.2

As an RTA, your laboratory has the following obligations:

- 1. the laboratory shall continue to meet all of the accreditation criteria of A2LA;
- the authorised representative of the laboratory shall notify NATA of changes to the staff or operations of the laboratory which would affect the performance of the tests for which the laboratory has been determined;
- 3. compliance of equipment shall be reported on test reports bearing the A2LA logo/endorsement.

Current information on the Australian Communications and Media Authority and regulatory requirements for telecommunications products within Australia can be obtained from the ACMA's web-site at "http://www.acma.gov.au. Further information about NATA may be gained by visiting "http://www.nata.asm.au.

Please note that AS/ACIF S040 and New Zealand standards do not form part of the RTA scheme.

Your RTA listing will appear on the NATA website shortly.

Kind Regards

Chris Norton,
Senior Scientific Officer
Measurement Science and Technology
National Association of Testing Authorities (NATA)
71-73 Flemington Road
North Melbourne Vic 3051
Australia
Ph: +61 3 9329 1633 Fx: +61 3 9326 5148

E-Mail: Christopher:Norton@nata.asn.au

Internet: www.nata.asn.au